



Digital Signal Processor for Karaoke Systems

Overview

The LC83026E provides the audio signal processing required in karaoke systems, including pitch shift, microphone echo, voice muting, and simple surround simulation. It is a special-purpose DSP that implements karaoke processing with the addition of a single external 256-Kb DRAM. The LC83026E includes on-chip A/D and D/A converters and supports both digital and analog inputs and outputs. Its functions and characteristics can be modified to match the needs of the end product by sending coefficient data from the microcontroller over a serial interface.

Features

- Application features
 - Pitch shift

The LC83026E supports pitch shifting of ± 15 quarter tone steps, or ± 1 octave in scale tone units as specified by command data. This pitch shifting can be applied either to the music track or to the microphone input. It is also possible to set up pitch shifting of ± 1 octave in arbitrary steps by setting coefficient values.

- Microphone echo

The LC83026E can apply echo processing to the input signal from the microphone A/D converter. The echo coefficients, including amount of echo and delay time, can be set.

— Voice muting

The LC83026E provides attenuation of monaural components in the music signal. This allows CDs that include vocals to be used for karaoke. The voice muting function is turned on or off by command data transferred over the serial interface.

- Simple surround

The LC83026E implements a simple surround simulation function by adding delay components to the music signal. The LC83026E includes six sets of simple surround coefficients as preset data, and these can be selected and switched using command data transferred over the serial interface. User-original surround effects can be implemented by setting

coefficients, but the algorithm is fixed.

— Versatile input mixing

The LC83026E supports hybrid mixing of digital music inputs and analog music inputs for both the left and right channels to support the processing of a wide range of disks.

· Audio inputs and outputs

Inputs: Digital One system (stereo)
 A/D converters Three channels
 Outputs: Digital One system (stereo)
 D/A converters Two channels

A/D converters

Second-order delta-sigma modulation

Three channels

D/A converters

2× oversampling digital filters + third-order noise shaper system
Two channels

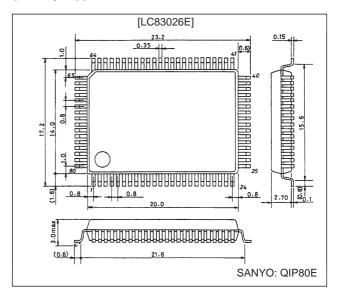
• Master clock: 768fs

- External memory: Up to two 256K $(64K \times 4 \text{ bits})$ external DRAMs can be used.
- Microcontroller input: Synchronous 8-bit serial data
- Power-supply voltage: 5V single-voltage supply
- Package: QFP80E

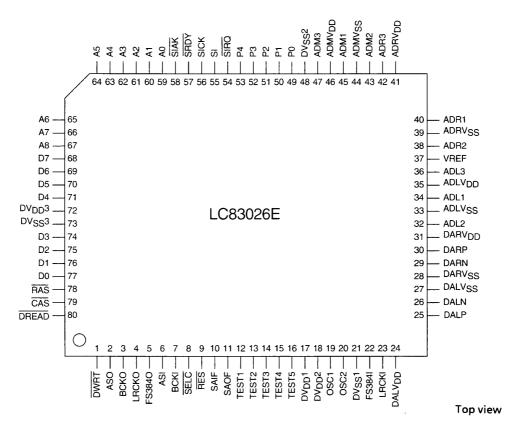
Package Dimensions

unit: mm

3174-QFP80E

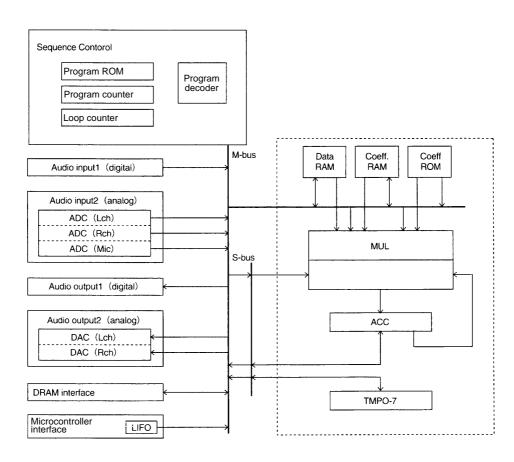


Pin Assignment



A07310

Block Diagram



Pin Functions

	Pin	Pin No.	I/O	Function
	OSC1	19	ı	Crystal oscillator connection (768fs)
	OSC2	20	0	Crystal oscillator connection (768fs)
	FS384I	22	ı	384fs input
	SELC	8	ı	Audio clock source switching (High: external, low: internal)
S	SAIF	10	ı	Digital audio input mode switching (Low: backward packing, high: forward packing)
l pin	SAOF	11	ı	Digital audio output mode switching (Low: 48fs, high 64fs)
Control pins	RES	9	ı	Reset
ပိ	TEST5 to 1	16 to 12	ı	Test (Must be connected to ground during normal operation.)
	P0	49	1	Coefficient transfer mode control
	P2 to P1	51, 50	1	Initial operating mode control (A high level should be applied for normal operation.)
	P3	52	0	Microphone signal input level: Yes (low output)/No (high output) output
	P4	53	0	Music signal input level: Yes (low output)/No (high output) output
ce	RAS	78	0	RAS signal output
terfa	CAS	79	0	CAS signal output
ry in	DREAD	80	0	External memory read signal output
emo	DWRT	1	0	External memory write signal output
alm	A8 to A0	67 to 59	0	Address output
External memory interface	D7 to D0	68 to 71,	I/O	Data input and output (Normally only D0 to D3 are used)
û		74 to 77		
	LRCKI	23	ı	ASI L/R clock input (1fs)
	LRCKO	4	0	ASO L/R clock output (1fs)
	BCKI	7	ı	ASI bit clock input (32fs or higher)
	ВСКО	3	0	ASO bit clock output (48fs or 64fs)
	FS384O	5	0	ASO 384fs output
	ASI	6	ı	Digital audio data input (16-bits, MSB first)
	ASO	2	0	Digital audio data output (16-bits, MSB first, backward packed)
on the	ADL1	34	ı	A/D converter input (left channel)
Audio interface	ADL2	32	0	A/D converter output (left channel)
inte	ADL3	36	0	A/D converter output (left channel)
dio	ADR1	40	ı	A/D converter input (right channel)
Au	ADR2	38	0	A/D converter output (right channel)
	ADR3	42	0	A/D converter output (right channel)
	ADM1	45		A/D converter input (microphone)
	ADM2	43	0	A/D converter output (microphone)
	ADM3	47	0	A/D converter output (microphone)
	DALP	25	0	D/A converter output (left channel)
	DALN	26	0	D/A converter output (left channel)
	DARP	30	0	D/A converter output (right channel)
-	DARN	29	0	D/A converter output (right channel)
Microcontroller interface	SIRQ	54	1	Input for the serial input request signal
er inte	SIAK	58	0	Output that indicates that a serial input is in progress
ontro	SI	55	 .	Serial data input from the control microcontroller (8-bit serial input)
licroco	SICK	56		SI pin transfer clock input
Σ	SRDY	57	ı	Ready signal input (from the control microcontroller) that indicates the completion of a serial data input.

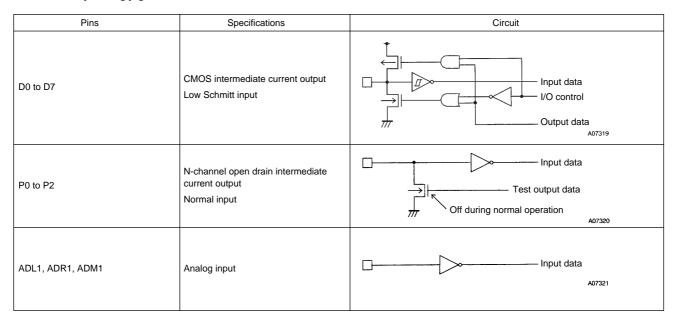
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	Pin	Pin No.	I/O		Function						
	DV _{DD} 1 to 3	17, 18, 72	_	Digital block V _{DD} (Must be connected to +5 V.)	al block V _{DD} (Must be connected to +5 V.)						
				<make as="" connections="" no="" possible="" poter<="" short="" so="" td="" that=""><td colspan="7">ake connections as short as possible so that no potential differences occur between any of the V_{DD} pins.></td></make>	ake connections as short as possible so that no potential differences occur between any of the V _{DD} pins.>						
	DV _{SS} 1 to 3	21, 48, 73	_	Digital block V _{SS} (Must be connected to ground.)	gital block V _{SS} (Must be connected to ground.)						
				<make as="" connections="" no="" possible="" poter<="" short="" so="" td="" that=""><td>ntial</td><td>differences occur between any of the V_{SS} pins.></td></make>	ntial	differences occur between any of the V _{SS} pins.>					
	ADLV _{DD}	35	_	A/D converter V _{DD} (left channel) (Connect to +5 V.)							
<u>></u>	ADRV _{DD}	41	_	A/D converter V _{DD} (right channel) (Connect to +5 V.)		Design the wiring so that potential differences do					
supply	$ADMV_DD$	46	_	A/D converter V _{DD} (microphone) (Connect to +5 V.)		not occur between the analog system V _{DD} pins and bither other analog system V _{DD} pins or the digital					
	DALV _{DD}	24	_	D/A converter V _{DD} (left channel) (Connect to +5 V.)	1	system V _{DD} pins.					
Power	DARV _{DD}	31	_	D/A converter V _{DD} (right channel) (Connect to +5 V.)							
	ADLV _{SS}	33	_	A/D converter V _{SS} (left channel) (Connect to ground.)		<u>`</u>					
	ADRV _{SS}	39	_	A/D converter V _{SS} (right channel) (Connect to ground.)		Design the wiring so that potential differences do					
	ADMV _{SS}	44	_	A/D converter V _{SS} (microphone) (Connect to ground.)	1	not occur between the analog system V _{SS} pins and					
	DALV _{SS}	27	_	D/A converter V _{SS} (left channel) (Connect to ground.)	1	oither other analog system V _{SS} pins or the digital system V _{SS} pins.					
	DARV _{SS}	28	_	D/A converter V _{SS} (right channel) (Connect to ground.)		,,sia 135 p.n.s.					

Pin Circuits

Pins	Specifications	Circuit
ASO, LRCKO, BCKO, RAS, CAS, DREAD, DWRT, FS384O, A0 to A8	TTL output	
P3, P4, SIAK	CMOS intermediate current output	Output data A07312
ADL2, ADL3, ADM2, ADM3, ADR2, ADR3		Output data
DALP, DALN, DARP, DARN	Analog output	Output data
SI, SICK, SIRQ, SRDY, (OSC1)	Schmitt input	∏ Input data
FS384I, BCKI, ASI, LRCKI	Low Schmitt input	A07315
TEST1 to TEST5	Normal input	Input data
RES	Input with built-in pull-up resistor	Input data A07317
SELC, SAIF, SAOF	Input with built-in pull-down resistor	Input data A07318
, 5,		→ - A07318

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Specifications Absolute Maximum Ratings at Ta = 25 $^{\circ} C,\,V_{SS}$ = 0 V

Parameter	Symbol	Conditions	Ratings	Unit	Notes
Maximum supply voltage	V _{DD} max		-0.3 to +7.0	V	
Input voltage	V _{IN}		-0.3 to V _{DD} +0.3	V	
Output voltage	V _O 1	OSC2 output	Values up to the oscillator voltage are allowable.	V	
	V _O 2	Outputs other than OSC2	-0.3 to V _{DD} +0.3	V	
	I _{OP} 1	Audio interface, external RAM interface	-2 to +4	mA	1
Peak output current	I _{OP} 2	Microcontroller interface, P3, P4	-2 to +10	mA	2
	I _{OA} 1	Audio interface, external RAM interface: Per pin	-2 to +4	mA	1
	I _{OA} 2	Microcontroller interface, P3, P4: Per pin	-2 to +10	mA	2
Average output current	Σl _{OA} 1	FS384O, LRCKO, BCKO, ASO : Total	-10 to +10	mA	
	Σl _{OA} 2	DWRT, DREAD, RAS, CAS, A0 to A8, D0 to D7, SIAK, P3, P4 : Total	-10 to +10	mA	
Allowable power dissipation	Pd max	Ta = -30 to +70°C	700	mW	
Operating temperature	Topr		-30 to +70	°C	
Storage temperature	Tstg		-40 to +125	°C	

Allowable Operating Ranges at Ta = -30 to +70 °C, all V_{DD} = 4.75 to 5.25 V, all V_{SS} = 0 V unless otherwise specified

Parameter	Symbol	Conditions		Linit	Notes		
Parameter	Symbol	Conditions	min	typ	max	Unit	Notes
Operating supply voltage	V _{DD}		4.75		5.25	V	
	V _{IH} 1	Audio interface and external RAM interface	2.4			V	4
Input high-level voltage	V _{IH} 2	P0 to P2, SELC, SAIF, SAOF, TEST1 to TEST5	0.7 V _{DD}			V	5
	V _{IH} 3	RES, OSC1, and the microcontroller interface	0.75 V _{DD}			V	6
	V _{IL} 1	Audio interface and external RAM interface			0.8	V	4
Input low-level voltage	V _{IL} 2	P0 to P2, SELC, SAIF, SAOF, TEST1 to TEST5			0.3 V _{DD}	V	5
	V _{IL} 3	RES, OSC1, and the microcontroller interface			0.25 V _{DD}	V	6
Instruction cycle time	t _{CYC}		58		59.11	ns	

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Parameter	Symbol	Conditions		Unit	Notes		
Parameter	Symbol	Conditions	min	typ	max	Uniii	notes
[External Clock Input Conditions]							
Frequency	f _{EXT}	Related to the FS384I pin. See Figure 1.	16.85		17.01	MHz	
6.1 .11	f _{EXTH}	maximum: 44.1 kHz × 384 × 1.005	23			ns	
Pulse width	f _{EXTL}	minimum: 44.1 kHz × 384 × 0.995	23			ns	
Rise time	t _{EXTR}				9	ns	
Fall time	t _{EXF}				9	ns	
[Self-Excited Oscillation Conditions(crystal os	cillator)]						
Oscillator frequency	fosc	OSC1 and OSC2. See Figure 2.	33.84		40.55	MHz	
Coomato:oqueoy	.030	44.1 kHz/48 kHz × 768 ±0.1%	00.01		.0.00		
Oscillator stabilization period	toscs	See Figure 3.			100	ms	
[Audio Data Input Conditions]							
Transfer bit clock period	t _{BCYC}	Related to BCKI. See Figure 4.	354			ns	
Transfer bit clock pulse width	t _{BCW}		100			ns	
Data setup time	t _S		70			ns	
Data hold time	t _H		70			ns	
[Serial I/O Clock Conditions]							
Serial clock period	tscyc		480			ns	
Serial clock pulse width	t _{SCW}		200			ns	
Data setup time	t _{SS}	Related to the microcontroller interface. See Figure 5. (Related to SICK, SI, and	70			ns	
Data hold time	t _{SH}	SRDY.)	70			ns	
SRDY hold time	t _{SYH}		200			ns	
SRDY pulse width	t _{SYW}		200			ns	
[DRAM Input Conditions]	•						
Input data setup time	t _{DSI}	Related to external DRAM data input. See	20			ns	
Input data hold time	t _{DHI}	Figure 6. (Related to CAS and D0 to D7.)	0			ns	

Electrical Characteristics 1 at Ta = -30 to $+70^{\circ}$ C, all V_{DD} = 4.75 to 5.25 V, all V_{SS} = 0 V unless otherwise specified

Doromotor	Cymphal	Conditions		Linit	Notes		
Parameter	Symbol	Conditions	min	typ	max	Unit	Notes
Input high-level current	I _{IH} 1	SELC, SAIF, SAOF, V _{IN} = V _{DD} (Input pins with pull-down resistors)		100	250	μA	8
input night-level current	I _{IH} 2	P0 to P2, $V_{IN} = V_{DD}$ (Nch transistor OFF)			10	μA	
	I _{IH} 3	Other input-only pins			10	μA	
	I _{IL} 1	RES, V _{IN} = V _{SS} (Input pins with pull-up resistors)	-250	-100		μА	8
Input low-level current	I _{IL} 2	P0 to P2, V _{IN} = V _{SS}	-10			μA	
	I _{IL} 3	Other input-only pins	-10			μA	
	V _{OH} 1	$I_{OH} = -0.4 \text{ mA}$	4.0	4.98		V	1, 8
Output high-level voltage	V _{OH} 2	I _{OH} = -50 μA	V _{DD} -1.2	4.997		V	2,3,8
0	V _{OL} 1	I _{OL} = 2 mA		0.065	0.4	V	1, 8
Output low-level voltage	V _{OL} 2	I _{OL} = 10 mA		0.32	1.5	V	2,3,8
Output off leakage current	I _{OFF}	$V_O = V_{SS}, V_{DD}$	-40		+40	μA	
Input and output capacitance	C _{IO}				10	pF	
[Audio Data Output Timing]	•		•				•
Output data hold time	t _{OH}	BCK0 and ASO. See Figure 7.	-30			ns	7
Output data delay time	t _{OD}				50	ns	7

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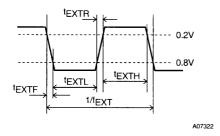
Parameter	Symbol	Conditions	Ratings			Unit	Notes
Farameter	Symbol	Conditions	min	typ	max	Oniii	ivotes
[External DRAM Access Timing]	•						-
RAS high-level pulse width	t _{RP}		80			ns	7
RAS low-level pulse width	t _{RAS}		700			ns	7
CAS high-level pulse width	t _{CP}		50			ns	7
CAS low-level pulse width	t _{CAS}		95			ns	7
CAS cycle time	t _{PC}		175			ns	7
RAS to CAS delay time	t _{RCD}		60			ns	7
CAS hold time	t _{CSH}		170			ns	7
RAS hold time	t _{RSH}	Output timing to the external DRAM. See Figure 8.	95			ns	7
RAS address setup time	t _{ASR}		60			ns	7
RAS address hold time	t _{RAH}		20			ns	7
CAS address setup time	t _{ASC}		30			ns	7
CAS address hold time	t _{CAH}		90			ns	7
DWRT pulse width	t _{WP}		95			ns	7
Write command setup time	t _{WCS}		12			ns	7
Write command hold time	t _{WCH}		65			ns	7
Output data setup time	t _{DSO}	Output timing to the external DRAM.	30			ns	7
Output data hold time	t _{DHO}	See Figure 8.	100			ns	7
	C1			13		pF	8
Crystal oscillator	C2	OSC1 and OSC2. See Figure 2.		29		pF	8
	L			1.5		μH	8
Current drain	I _{DD}	For V _{DD} 1, V _{DD} 2, and V _{DD} 3 when operating at 33.8688 MHz.		60	95	mA	9

Electrical Characteristics 2 at $Ta = 25^{\circ}C$, all $V_{DD} = 5.0 \text{ V}$, all $V_{SS} = 0 \text{ V}$ unless otherwise specified

Parameter	Cymphal	Conditions	Ratings				Notes
Parameter	Symbol	Conditions	min	typ	max	Unit	notes
[A/D Converter Block]							
Total harmonic distortion	A-THD	1 kHz, at 0 dB		0.05		%	10
Signal-to-noise ratio	A-S/N	1 kHz, at 0 dB	75	80		dB	10,11
Crosstalk	A-C · T	1 kHz, at 0 dB		-75		dB	10,11
[D/A Converter Block]							
Total harmonic distortion	D-THD	1 kHz, at 0 dB		0.01		%	10
Signal-to-noise ratio	D-S/N	1 kHz, at 0 dB		85		dB	10,11
Crosstalk	D-C · T	1 kHz, at 0 dB		-80		dB	10,11

 $Notes: \quad \text{1. TTL output level pins: ASO, FS384O, BCKO, LRCKO, D0 to D7, A0 to A8, \overline{RAS}, $\overline{\overline{CAS}}$, $\overline{\overline{DREAD}}$, $\overline{\overline{DWRT}}$ and $\overline{\overline{NS}}$. The second content of the property of$

- 2. CMOS intermediate current output pins: P3, P4, SIAK
- 3. N-channel open drain intermediate current output pins: P0 to P2
- 4. Low Schmitt input pins: BCKI, ASI, LRCKI, D0 to D7, FS384I
- 5. Normal input pins: P0 to P2, TEST1 to TEST5, SELC, SAIF, SAOF
- 6. Schmitt input pins: \overline{RES} , SI, SICK, \overline{SIRQ} , \overline{SRDY} , OSC1
- 7. When the load capacitance is 50 pF.
- 8. The values for the oscillator capacitors C1 and C2 include the line capacitances.
- 9. The typical values for the current drain are for $V_{DD} = 5 \text{ V}$, room temperature, and typical samples.
- 10. Fs = 44.1 kHz and 20 kHz low-pass filter used. Measurement is with the external circuit structure and constants in the Sanyo evaluation board.
- 11. With the weight A filter used.



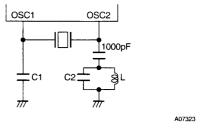


Figure 1 External Clock Input Waveform (FS384I)

Figure 2 Crystal Oscillator Circuit

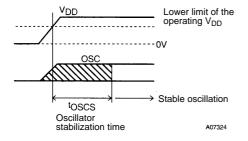
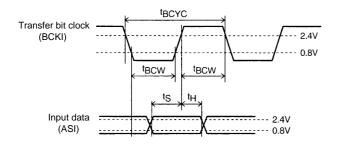


Figure 3 Oscillator Stabilization Time



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Figure 4 Audio Data Input Conditions

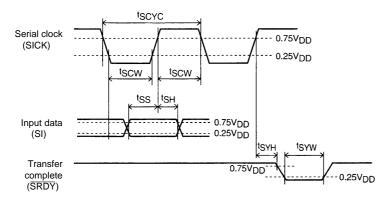
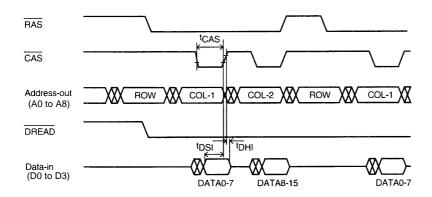
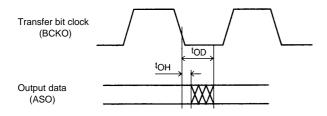


Figure 5 Microcontroller Interface



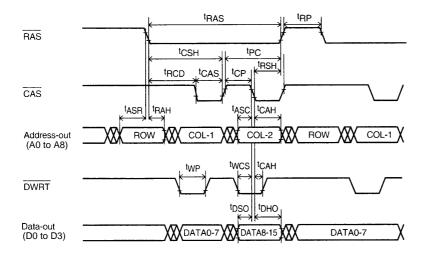
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Figure 6 External DRAM Data Input Timing



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Figure 7 Audio Data Output Timing



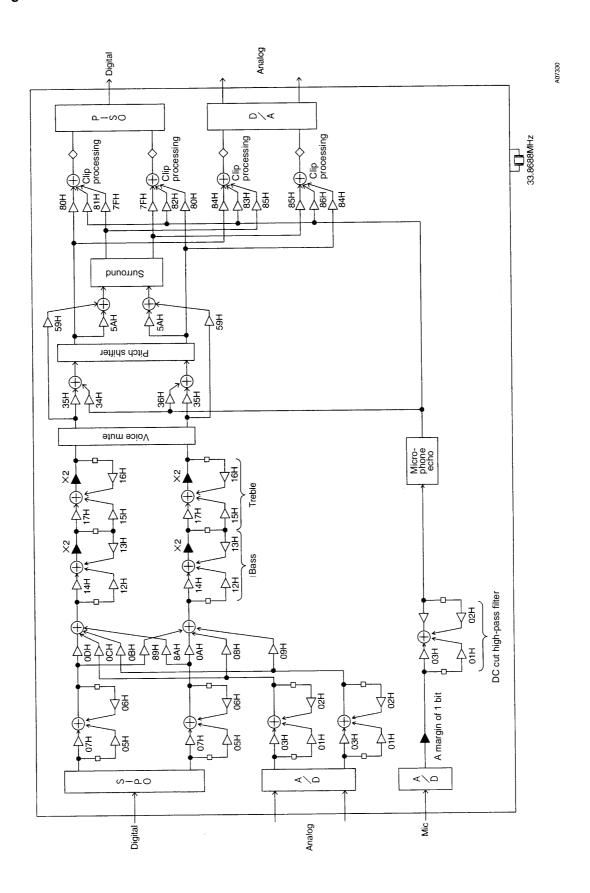
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Figure 8 External DRAM Data Output Timing

Differences between the LC83025E and the LC83026E

Parameter	LC83025E	LC83026E					
	Decimation filter improved						
	Input compar	rator improved					
A/D converter block	*: The V _{REF} pin was added in association with the improvements to the input comparator. The V _{REF} pin external capacitor must be located as close as possible to the LC83026E, and must be connected with lines that are as short as possible.						
	4 × oversampling filters used	2 × oversampling filters used					
D/A converter block	Second-order noise shaping	Third-order noise shaping					
	Single-pin output used.	Two-pin output operation					
Reset time	One or more sampling period	Two or more sampling periods					
When no digital input is provided (when the SELC pin is low)	The LRCKI and BCKI pins must be connected to the LRCKO and BCKO pins.	The LRCKI and BCKI pins must be connected to either V _{DD} or V _{SS} ; they do not need to be connected to the LRCKO and BCKO pins.					

Overall Signal Flow





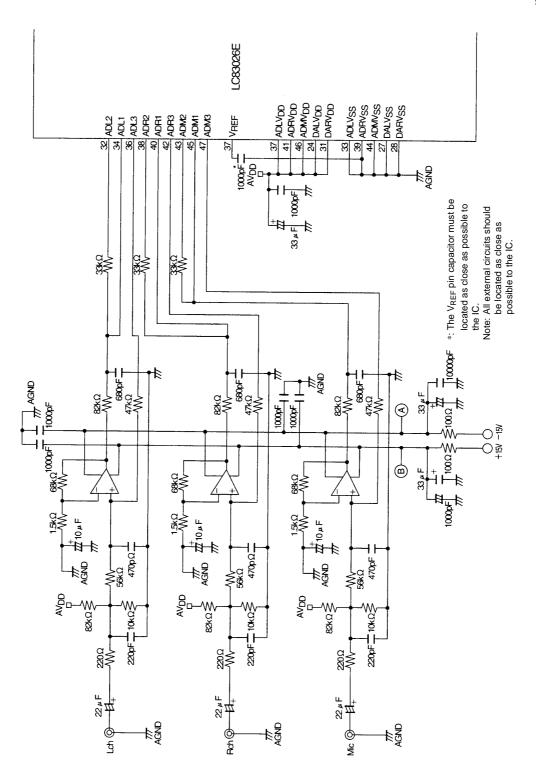


Figure 9 A/D Converter External Circuit Example

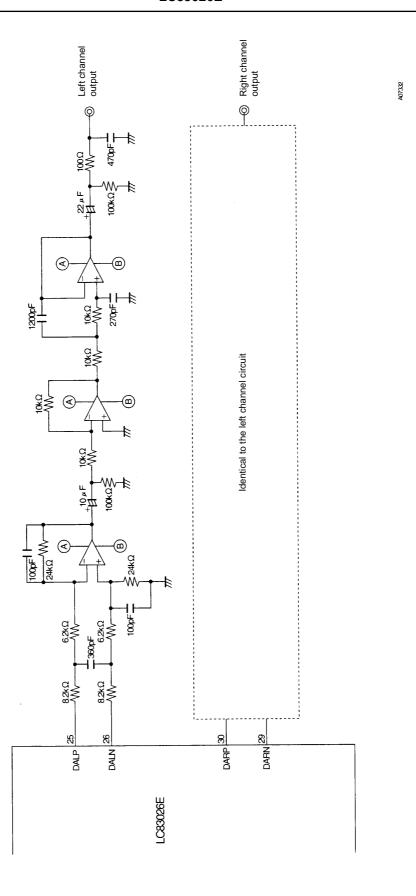
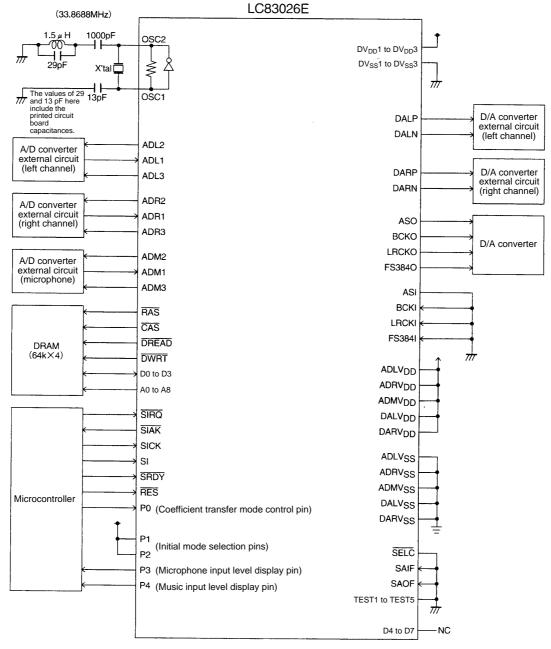


Figure 10 D/A Converter External Circuit Example

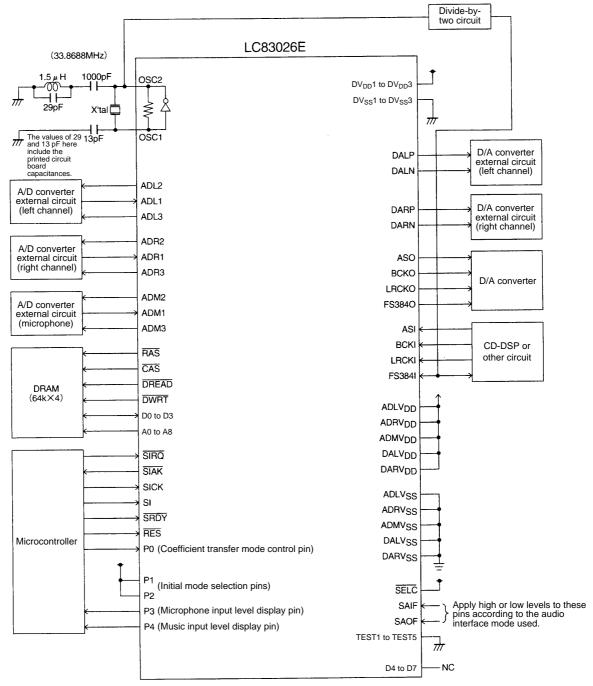
Application Circuit Example Outline (When digital input is not used)



Whether or not the digital inputs and/or analog outputs are used depends on the specifications of the application.

If any of these pins are not used, any unused input pins should be tied to high or low and any unused output pins should be left open.

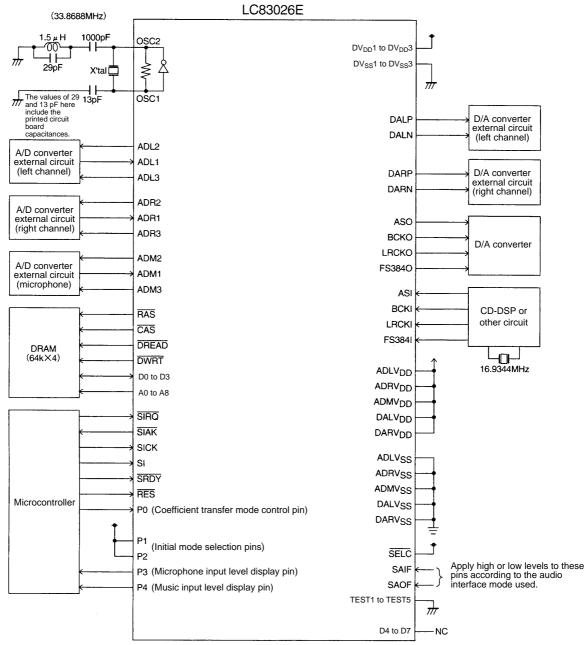
Application Circuit Example Outline (When digital input is used 1)



Whether or not the digital inputs and/or analog outputs are used depends on the specifications of the application.

If any of these pins are not used, any unused input pins should be tied to high or low and any unused output pins should be left open.

Application Circuit Example Outline (When digital input is used 2)



Whether or not the digital inputs and/or analog outputs are used depends on the specifications of the application.

If any of these pins are not used, any unused input pins should be tied to high or low and any unused output pins should be left open.

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